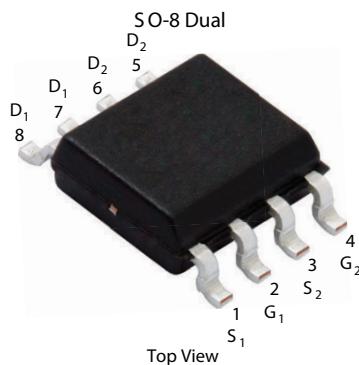


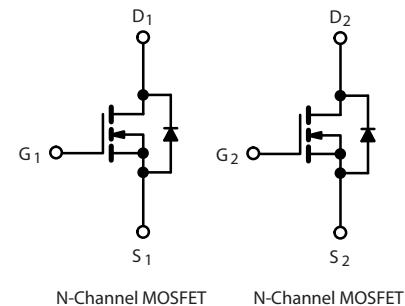
Dual N-Channel 60 V (D-S) 175 °C MOSFET

PRODUCT SUMMARY	
V _{DS} (V)	60
R _{DS(on)} (Ω) at V _{GS} = 10 V	0.040
R _{DS(on)} (Ω) at V _{GS} = 4.5 V	0.055
I _D (A) per leg	7
Configuration	Dual



FEATURES

- TrenchFET® power MOSFET
- 100 % R_g and UIS tested



ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)				
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V _{DS}	60	V
Gate-Source Voltage		V _{GS}	± 20	
Continuous Drain Current	T _C = 25 °C	I _D	7	A
	T _C = 125 °C		4	
Continuous Source Current (Diode Conduction) ^a		I _S	3.6	
Pulsed Drain Current ^b		I _{DM}	28	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	18	
Single Pulse Avalanche Energy		E _{AS}	16.2	mJ
Maximum Power Dissipation ^b	T _C = 25 °C	P _D	4	W
	T _C = 125 °C		1.3	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C

THERMAL RESISTANCE RATINGS				
PARAMETER		SYMBOL	LIMIT	UNIT
Junction-to-Ambient	PCB Mount ^c	R _{thJA}	110	°C/W
Junction-to-Foot (Drain)		R _{thJF}	34	

Notes

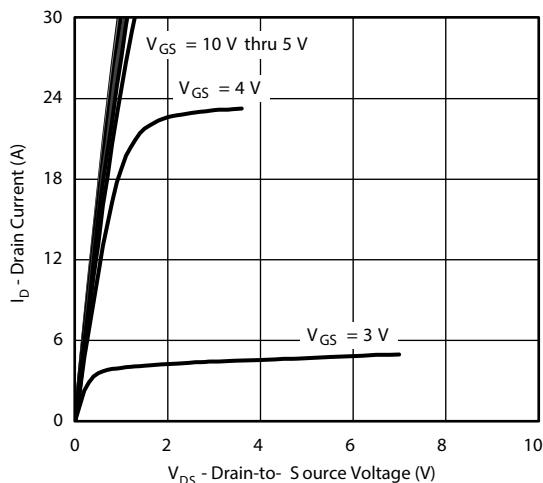
- Package limited.
- Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.
- When mounted on 1" square PCB (FR4 material).

SPECIFICATIONS ($T_C = 25^\circ\text{C}$, unless otherwise noted)									
PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.		
Static									
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0\text{ V}$, $I_D = 250\text{ }\mu\text{A}$	60	-	-	V			
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$	1.5	2.0	2.5				
Gate-Source Leakage	I_{GSS}	$V_{DS} = 0\text{ V}$, $V_{GS} = \pm 20\text{ V}$	-	-	± 100	nA			
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS} = 0\text{ V}$	$V_{DS} = 60\text{ V}$	-	-	1	μA		
		$V_{GS} = 0\text{ V}$	$V_{DS} = 60\text{ V}$, $T_J = 125^\circ\text{C}$	-	-	50			
		$V_{GS} = 0\text{ V}$	$V_{DS} = 60\text{ V}$, $T_J = 175^\circ\text{C}$	-	-	150			
On-State Drain Current ^a	$I_{D(\text{on})}$	$V_{GS} = 10\text{ V}$	$V_{DS} \geq 5\text{ V}$	20	-	-	A		
Drain-Source On-State Resistance ^a	$R_{DS(\text{on})}$	$V_{GS} = 10\text{ V}$	$I_D = 4.5\text{ A}$ -	0.028	0.040		Ω		
		$V_{GS} = 10\text{ V}$	$I_D = 4.5\text{ A}$, $T_J = 125^\circ\text{C}$	-	-	0.066			
		$V_{GS} = 10\text{ V}$	$I_D = 4.5\text{ A}$, $T_J = 175^\circ\text{C}$	-	-	0.081			
		$V_{GS} = 4.5\text{ V}$	$I_D = 4\text{ A}$ -	0.030	0.055				
Forward Transconductance ^f	g_{fs}	$V_{DS} = 15\text{ V}$, $I_D = 4.5\text{ A}$			-	15	-	S	
Dynamic ^b									
Input Capacitance	C_{iss}	$V_{GS} = 0\text{ V}$	$V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$	-	600	7 50	pF		
Output Capacitance	C_{oss}			-	110	140			
Reverse Transfer Capacitance	C_{rss}			-	50	62			
Total Gate Charge ^c	Q_g	$V_{GS} = 10\text{ V}$	$V_{DS} = 30\text{ V}$, $I_D = 5.3\text{ A}$	-	11.7	18	nC		
Gate-Source Charge ^c	Q_{gs}			-	1.8	2.7			
Gate-Drain Charge ^c	Q_{gd}			-	2.8	4.2			
Gate Resistance	R_g	$f = 1\text{ MHz}$			1.3	-	6	Ω	
Turn-On Delay Time ^c	$t_{d(\text{on})}$	$I_D = 4.4\text{ A}$, $V_{DD} = 30\text{ V}$, $R_L = 6.8\text{ }\Omega$, $V_{GEN} = 10\text{ V}$, $R_g = 1\text{ }\Omega$		-	7	11	ns		
Rise Time ^c	t_r			-	3.3	5			
Turn-Off Delay Time ^c	$t_{d(\text{off})}$			-	22.4	33.5			
Fall Time ^c	t_f			-	2.1	3.2			
Source-Drain Diode Ratings and Characteristics ^b									
Pulsed Current ^a	I_{SM}				-	-	28	A	
Forward Voltage	V_{SD}	$I_F = 2\text{ A}$, $V_{GS} = 0\text{ V}$			-	0.75	1.1	V	

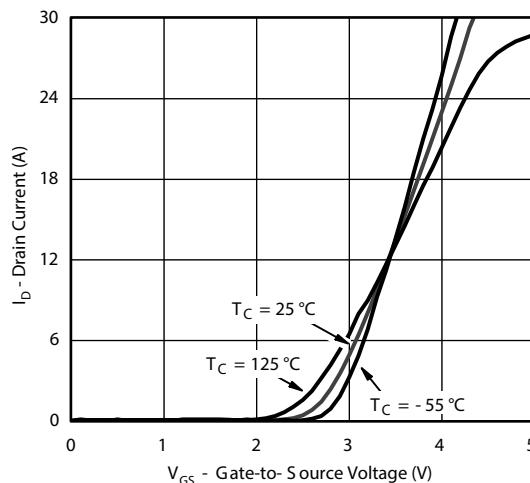
Notes

- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

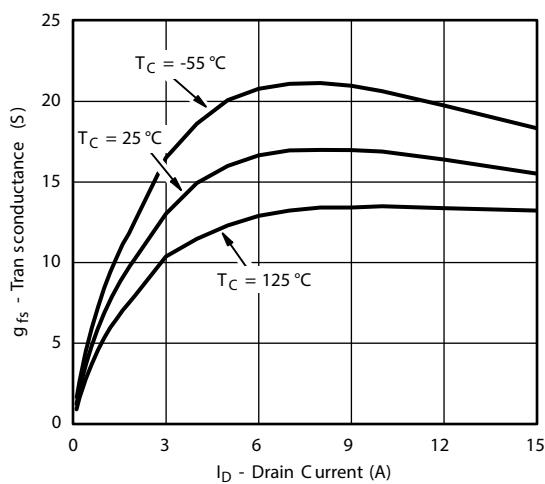
TYPICAL CHARACTERISTICS

 $(T_A = 25^\circ\text{C}$, unless otherwise noted)

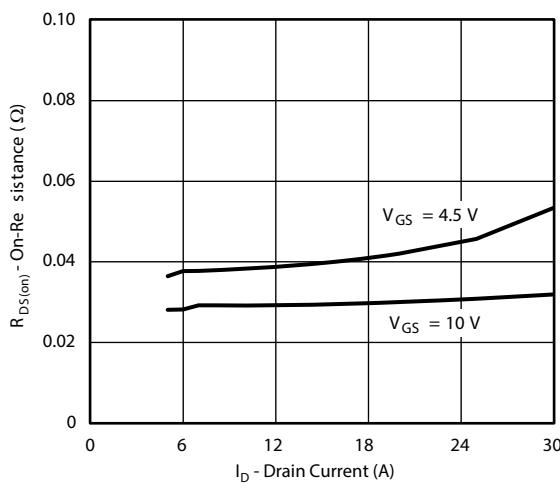
Output Characteristics



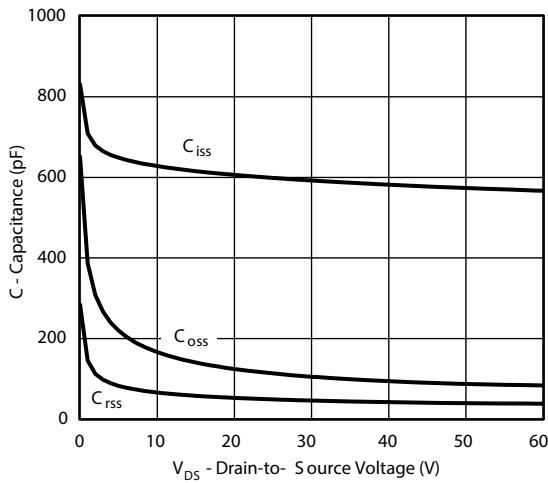
Transfer Characteristics



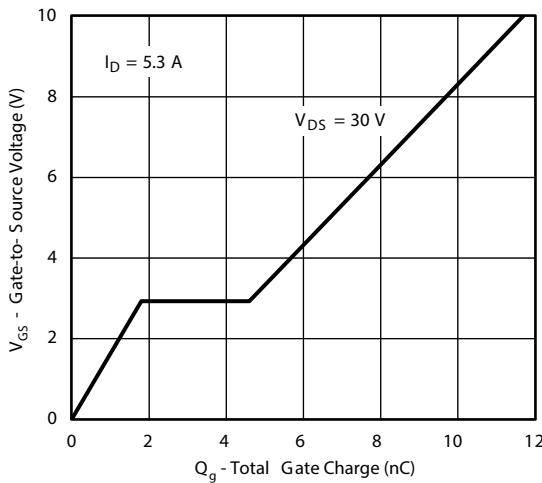
Transconductance



On-Resistance vs. Drain Current

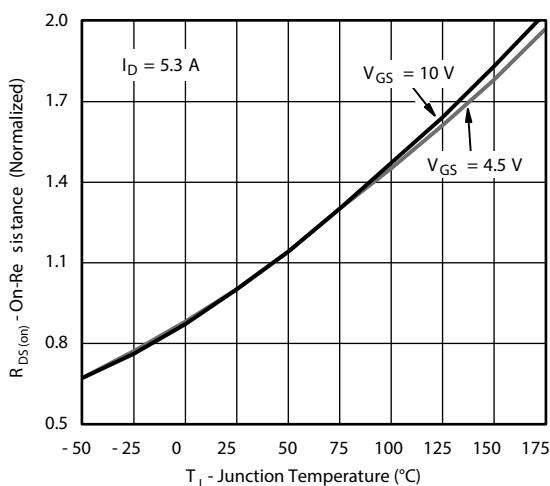


Capacitance

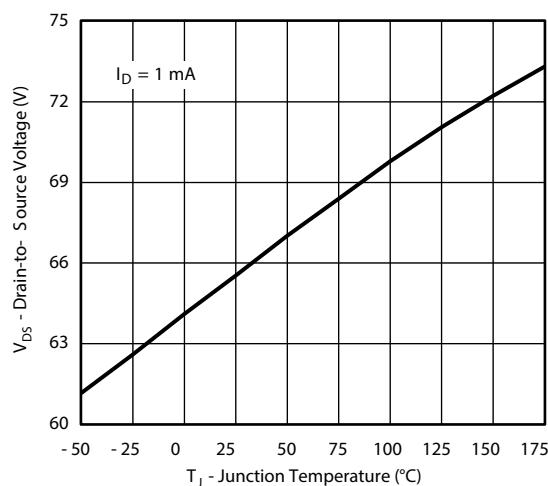


Gate Charge

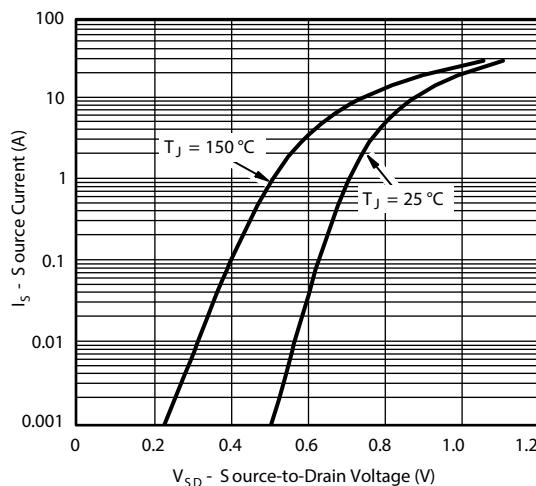
TYPICAL CHARACTERISTICS

 $(T_A = 25^\circ\text{C}, \text{unless otherwise noted})$ 

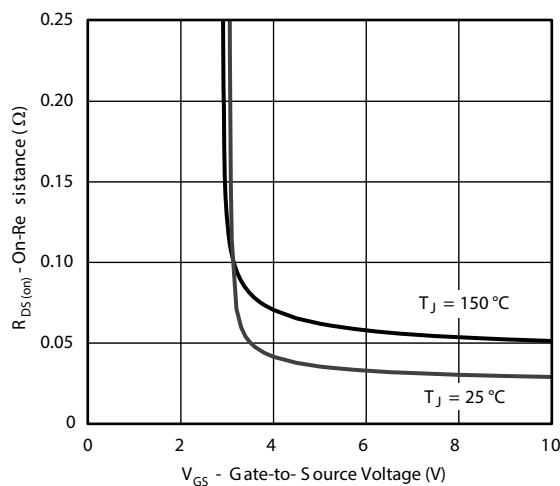
On-Resistance v.s. Junction Temperature



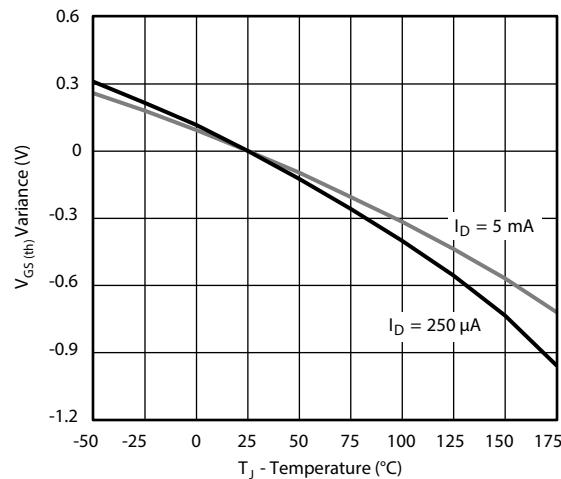
Drain Source Breakdown vs. Junction Temperature



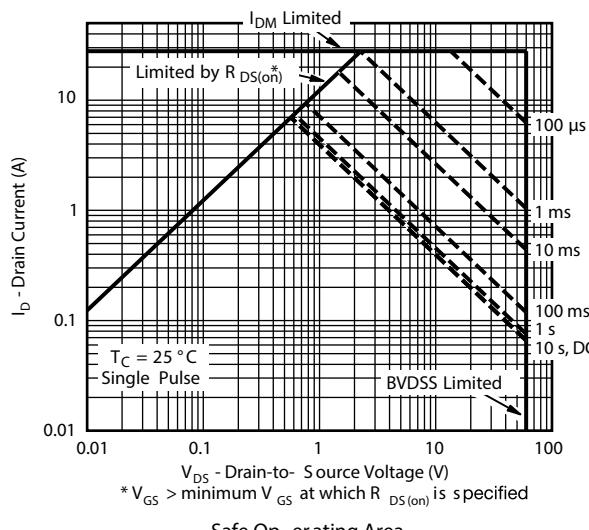
Source Drain Diode Forward Voltage



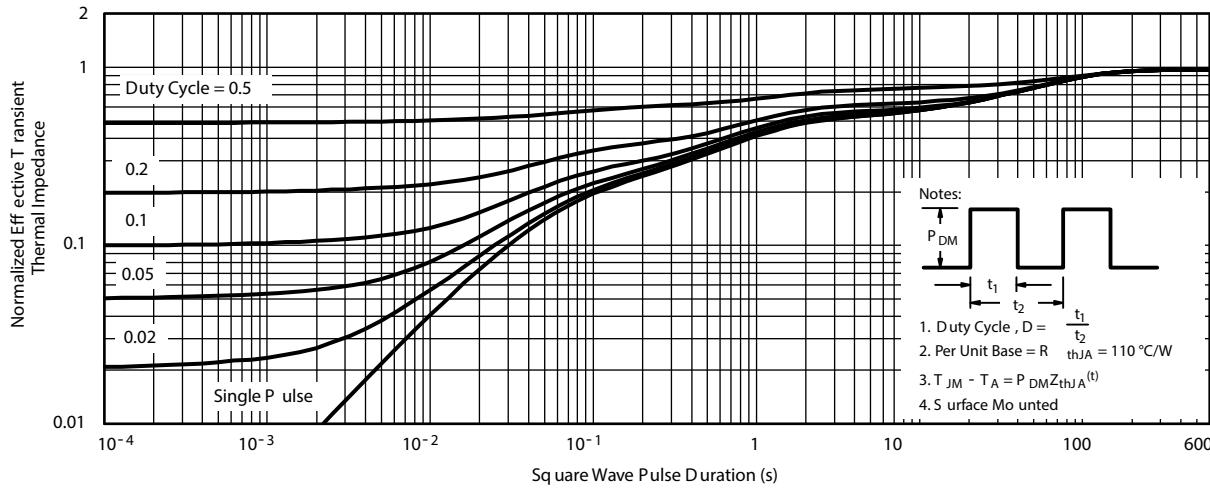
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

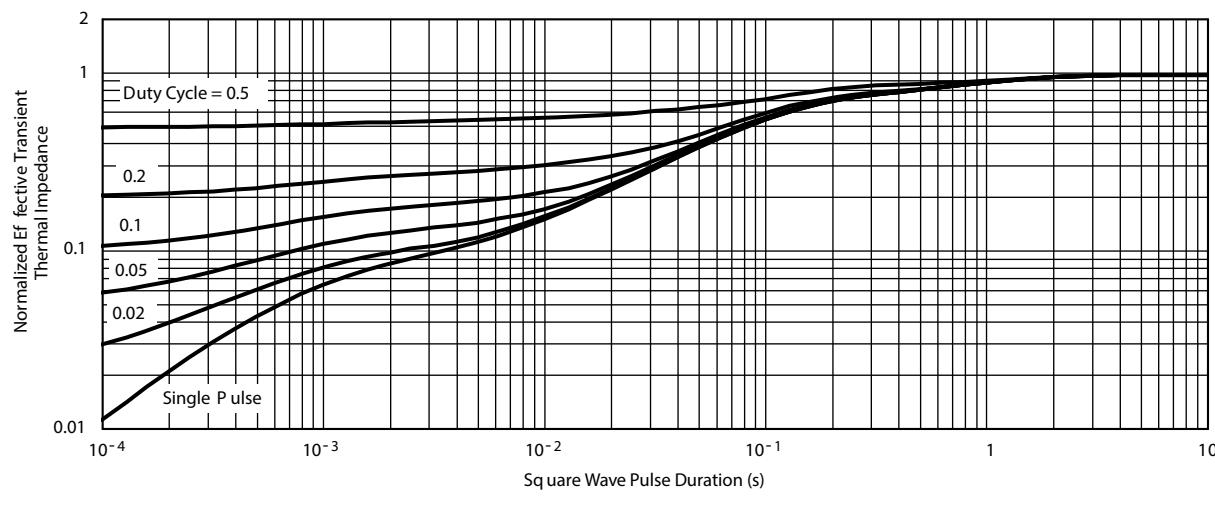
THERMAL RATINGS ($T_A = 25^\circ\text{C}$, unless otherwise noted)

Safe Operating Area



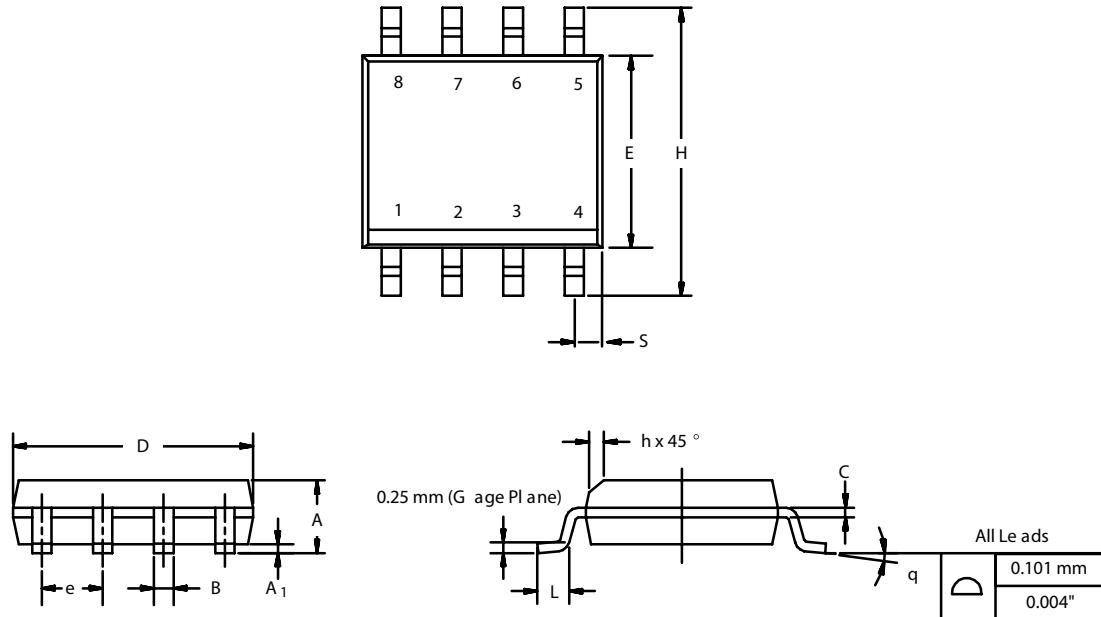
Normalized Thermal Transient Impedance, Junction-to-Ambient

THERMAL RATING S ($T_A = 25^\circ\text{C}$, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Foot

S OIC (NARROW): 8-LEAD
JEDEC Part Number: M S -012



DIM	MILLIMETERS		INCHES	
	Min	Max	Min	Max
A	1.35	1.75	0.053	0.069
A ₁	0.10	0.20	0.004	0.008
B	0.35	0.51	0.014	0.020
C	0.19	0.25	0.0075	0.010
D	4.80	5.00	0.189	0.196
E	3.80	4.00	0.150	0.157
e	1.27 BSC		0.050 BSC	
H	5.80	6.20	0.228	0.244
h	0.25	0.50	0.010	0.020
L	0.50	0.93	0.020	0.037
q	0°	8°	0°	8°
S	0.44	0.64	0.018	0.026

ECN: C-06527-Rev. I, 11-Sep-06
DWG: 5498

RECOMMENDED MINIMUM PADS FOR SO-8

